


<b>Search Notes</b> 	<b>Application/Control No.</b> 10567121	<b>Applicant(s)/Patent Under Reexamination</b> HATANO ET AL.
	<b>Examiner</b> NAISHADH N DESAI	<b>Art Unit</b> 2834

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
Searched 310/91 with keywords	10/27/2008	NND
IDS and INV search	10/27/2008	NND
Global search with keywords	10/27/2008	NND

INTERFERENCE SEARCH			
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